SN54ABT162823A . . . WD PACKAGE

SCBS666B - JULY 1996 - REVISED JUNE 2004

- Members of the Texas Instruments Widebus™ Family
- Output Ports Have Equivalent 25-Ω Series Resistors So No External Resistors Are Required
- Typical V_{OLP} (Output Ground Bounce)
 <1 V at V_{CC} = 5 V, T_A = 25°C
- High-Impedance State During Power Up and Power Down
- I_{off} and Power-Up 3-State Support Hot Insertion
- Distributed V_{CC} and GND Pins Minimize High-Speed Switching Noise
- Flow-Through Architecture Optimizes PCB Layout

description/ordering information

These 18-bit bus-interface flip-flops feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing wider buffer registers, I/O ports, bidirectional bus drivers with parity, and working registers.

The 'ABT162823A devices can be used as two 9-bit flip-flops or one 18-bit flip-flop. With the clock-enable (CLKEN) input low, the D-type flip-flops enter data on the low-to-high transitions of the clock. Taking CLKEN high disables the clock buffer, thus latching the outputs. Taking the clear (CLR) input low causes the Q outputs to go low independently of the clock.

SN74ABT162823A DGG OR DL PACKAGE								
(TOP VIEW)								
1 <u>CLR</u> 1 <u>OE</u> 1Q1 GND 1Q2 1Q3 V _{CC} 1Q4 1Q5 1Q6 GND 1Q7 1Q8	(TOP VII 1 2 3 4 5 6 7 8 9 10 11 12 13	56 55 54 53 52 51 50 49 48 47 46 45 44	1CLK 1CLKEN 1D1 GND 1D2 1D3 V _{CC} 1D4 1D5 1D6 GND 1D7 1D8					
1Q8 1Q9 2Q1 2Q2 2Q3 GND 2Q4 2Q4 2Q5 2Q6 VCC	13 14 15 16 17 18 19 20 21 22	44 43 42 41 40 39 38 37 36 35	1D8 1D9 2D1 2D2 2D3 GND 2D4 2D5 2D6 V _{CC}					
2Q7 [2Q8 [GND [2Q9 [2 <u>OE</u> [2CLR [23 24	34 33 32	2D7 2D8 GND 2D9					

ORDERING INFORMATION

TA	PACKAGE [†]		ORDERABLE PART NUMBER	TOP-SIDE MARKING		
		Tube	SN74ABT162823ADL	ABT160900A		
-40°C to 85°C	SSOP – DL	Tape and reel	SN74ABT162823ADLR	ABT162823A		
	TSSOP – DGG	Tape and reel	SN74ABT162823ADGGR	ABT162823A		
–55°C to 125°C	CFP – WD	Tube	SNJ54ABT162823AWD	SNJ54ABT162823AWD		

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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SN54ABT162823A, SN74ABT162823A 18-BIT BUS-INTERFACE FLIP-FLOPS WITH 3-STATE OUTPUTS SCBS666B – JULY 1996 – REVISED JUNE 2004

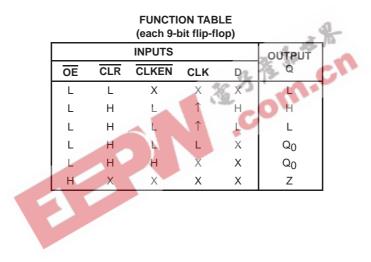
description/ordering information (continued)

A buffered output-enable (\overline{OE}) input places the nine outputs in either a normal logic state (high or low level) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components. \overline{OE} does not affect the internal operation of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The outputs, which are designed to source or sink up to 12 mA, include equivalent $25-\Omega$ series resistors to reduce overshoot and undershoot.

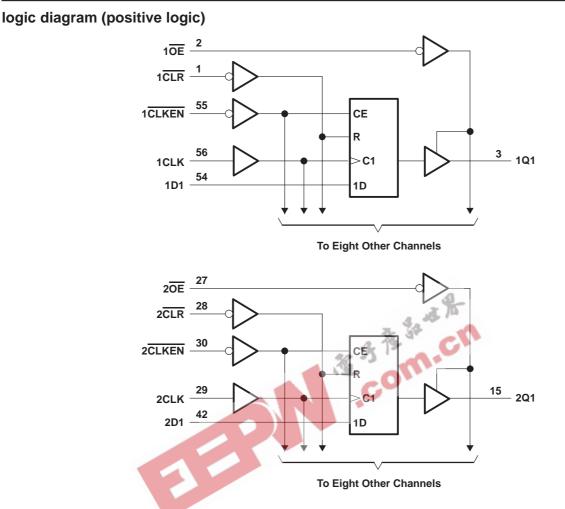
These devices are fully specified for hot-insertion applications using I_{off} and power-up 3-state. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.

To ensure the high-impedance state during power up or power down, \overline{OE} shall be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V _I (see Note 1)	
Voltage range applied to any output in the high or power-off state, Vo	
Current into any output in the low state, IO	30 mA
Input clamp current, I _{IK} (V _I < 0)	
Output clamp current, I_{OK} ($V_O < 0$)	–50 mA
Package thermal impedance, θ_{JA} (see Note 2): DGG package	
DL package	56°C/W
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.



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recommended operating conditions (see Note 3)

			SN54ABT1	62823A	SN74ABT1	62823A	
			MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage		4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2	Å	2		V	
VIL	Low-level input voltage		\$ 0.8		0.8	V	
VI	Input voltage	0	Vcc	0	VCC	V	
ЮН	High-level output current		1	-3		-12	mA
IOL	Low-level output current		200	8		12	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	Outputs enabled	201	10		10	ns/V
$\Delta t / \Delta V_{CC}$	Input transition rise or fall rate		Q 200		200		μs/V
Т _А	Operating free-air temperature		-55	125	-40	85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

			T _A = 25°C			SN54ABT162823A		SN74ABT162823A		
PARAMETER	TEST CONDITIONS			TYP [†]	MAX	MIN 🧨	MAX	MIN	MAX	UNIT
VIK	V _{CC} = 4.5 V,	lj = -18 mA		. %	-1.2	1	-1.2		-1.2	V
	V _{CC} = 4.5 V,	$I_{OH} = -1 \text{ mA}$	2.5	1.3	-	2.5		2.5		
Maria	V _{CC} = 5 V,	$I_{OH} = -1 \text{ mA}$	3		0	3		3		V
VOH		$I_{OH} = -3 \text{ mA}$	2.4			2.4		2.4		V
	$V_{CC} = 4.5 V$	$I_{OH} = -12 \text{ mA}$	2*					2		
Ma.		I _{OL} = 8 mA		0.4			0.8		0.65	V
VOL	V _{CC} = 4.5 V	l _{OL} = 12 mA			0.8*				0.8	V
Ц	V _{CC} = 5.5 V,	$V_{I} = V_{CC} \text{ or } GND$			±1		±1		±1	μΑ
IOZPU	$V_{CC} = 0$ to 2.1 V, $V_{O} = 0.5$ V to 2.7 V, C	$\overline{\mathbf{E}} = \mathbf{X}$			±50	4	±50		±50	μΑ
IOZPD	$V_{CC} = 2.1 V \text{ to } 0,$ $V_{O} = 0.5 V \text{ to } 2.7 V, \overline{C}$	$\overline{DE} = X$			±50	C7 B	±50		±50	μΑ
IOZH [‡]	V _{CC} = 5.5 V,	V _O = 2.7 V			10	ng	10		10	μA
Iozl‡	V _{CC} = 5.5 V,	$V_{O} = 0.5 V$			-10	RO	-10		-10	μA
loff	$V_{CC} = 0,$	$V_{I} \text{ or } V_{O} \leq 4.5 \text{ V}$			±100	4			±100	μA
ICEX	V _{CC} = 5.5 V, V _O = 5.5 V	Outputs high			50		50		50	μΑ
ΙΟ§	V _{CC} = 5.5 V,	$V_{O} = 2.5 V$	-25	-55	-100	-25	-100	-25	-100	mA
	V _{CC} = 5.5 V,	Outputs high			0.5		0.5		0.5	
ICC	$I_{O} = 0,$	Outputs low			80		80		80	mA
	$V_{I} = V_{CC}$ or GND	Outputs disabled			0.5		0.5		0.5	
${}^{\Delta I}CC^{\P}$	$V_{CC} = 5.5 V$, One inp Other inputs at V_{CC} of				1.5		1.5		1.5	mA
Ci	VI = 2.5 V or 0.5 V			3.5						pF
Co	V _O = 2.5 V or 0.5 V			9						pF

* On products compliant to MIL-PRF-38535, this parameter does not apply.

[†] All typical values are at V_{CC} = 5 V.

[‡] The parameters I_{OZH} and I_{OZL} include the input leakage current.

§ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

 \P This is the increase in supply current for each input that is at the specified TTL-voltage level, rather than V_{CC} or GND.

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timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

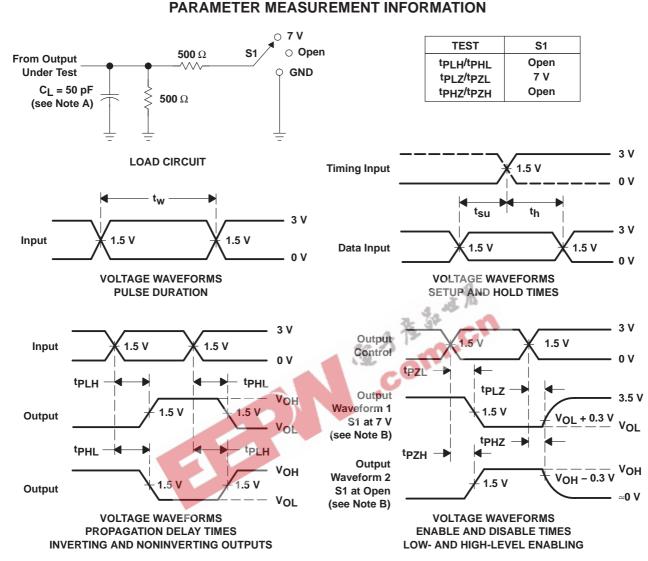
			V _{CC} = T _A = 2	= 5 V, 25°C	SN54ABT1	62823A	SN74ABT1	62823A	UNIT	
			MIN	MAX	MIN	MAX	MIN	MAX		
fclock	Clock frequency			150		150		150	MHz	
	Dulas duration	CLR low	3.3		3.3	-IN	3.3			
tw	Pulse duration	CLK high or low	3.3		3.3	N.	3.3		ns	
		CLR inactive	1.6		2	27	1.6		ns	
t _{su}	Setup time before $CLK\uparrow$	Data	2		2		2			
		CLKEN low	2.8		2,8		2.8			
		Data	1.2		21.2		1.2			
^t h	Hold time after CLK↑	CLKEN low	0.6		v 0.6		0.6		ns	

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	RAMETER FROM				V _{CC} = 5 V, T _A = 25°C			SN54ABT162823A		SN74ABT162823A		UNIT
	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX			
f _{max}			150	x 3		150		150		MHz		
^t PLH		0	2.3	4.6	6.2	2.3	8.4	2.3	7.5			
^t PHL	CLK	Q	2.8	4.6	6.1	2.8	7.1	2.8	6.7	ns		
^t PHL	CLR	Q	2.8	5	6.3	2.8	7.2	2.8	7	ns		
^t PZH	OE		1.7	3.8	5	1.7	5.8	1.7	5.9			
^t PZL	OE	Q	3	5	6.1	03	7.2	3	7	ns		
^t PHZ	OE		2.6	4.8	6.1	2.6	7.3	2.6	6.6			
^t PLZ	OE	Q	1.9	4.6	6.7	1.9	10.2	1.9	9	ns		



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NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2.5 ns. t_f \leq 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms



6-Dec-2006

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
74ABT162823ADGGRE4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ABT162823ADLRG4	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT162823ADGGR	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT162823ADL	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT162823ADLG4	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT162823ADLR	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. **TBD**: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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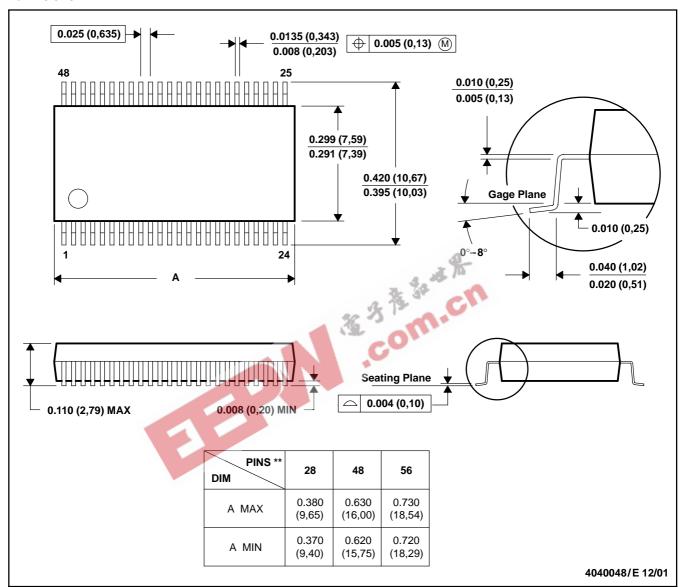
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MECHANICAL DATA

MSSO001C - JANUARY 1995 - REVISED DECEMBER 2001

PLASTIC SMALL-OUTLINE PACKAGE

DL (R-PDSO-G**) 48 PINS SHOWN



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NOTES: A. All linear dimensions are in inches (millimeters).

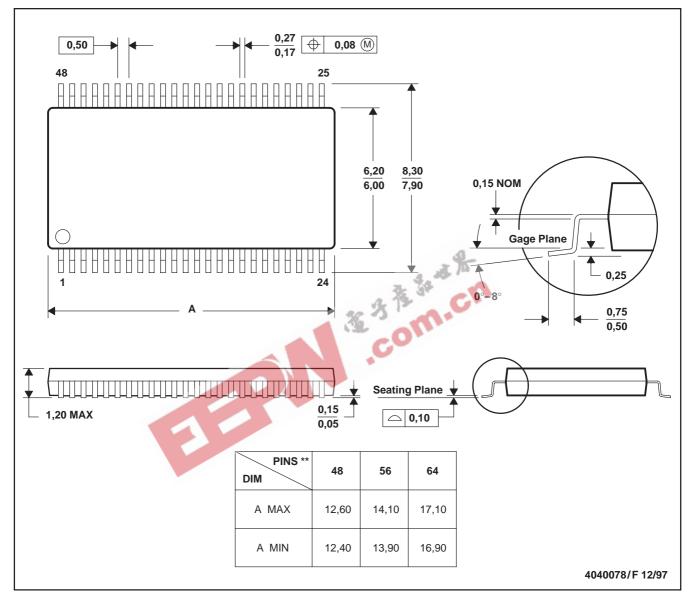
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MO-118

MECHANICAL DATA

MTSS003D - JANUARY 1995 - REVISED JANUARY 1998

PLASTIC SMALL-OUTLINE PACKAGE

DGG (R-PDSO-G**) 48 PINS SHOWN



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B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153



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